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LIST OF	REFE	RENCES CITED BY APP	LICANT	APPLICANT Kenji OKAHARA, et al.						
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				U.S. PATENT DOCUM	ENTS				<u>' · · · · · · · · · · · · · · · · · · ·</u>	
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72	AM	2001-15172	01/19/01	JP			anst	That	No	
ICU	AN	62-86673	04/21/87	JP					No	
TSV.) AO	10-308236	11/17/98	JP					No	
المنك	AP	7-235327	09/05/95	JP			abo	hoo	No	
414	AQ	54-35329	03/15/79	JP					No	
150	AR	548660	06/30/93	EP					No	
4	AS	2068631	08/12/81	GB			als	IN.	No	
4	1	10-112422	04/28/98	JP			about	no	No	
45	AU	10-74537	03/17/98	JP					No	
4	AV	58-214281	12/13/83	JP					No	
		OTHER REF	ERENCES (Including Author, Title	, Date, Pertinent	Pages, et	ic.)			
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*Examiner: In conformance	itial if r	reference is considered, w considered. Include cop	hether or not by of this form	citation is in conforman with next communication	ce with MPEP 60 on to applicant.	9; Draw lin	e through	citation if	not in	